Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/672,151	JACOBS ET AL.	
Examiner	Art Unit	
Binh X. Tran	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
438	712	12/21/2005	вт		
438	723	12/21/2005	ВТ		
438	724	12/21/2005	вт		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Update search	12/21/2005	вт	
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